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L1	2	("20020114519").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	OFF	2005/01/28 15:35
L2	2	("6519607").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	OFF	2005/01/28 15:36
L3	2	("6373047").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	OFF	2005/01/28 15:36
L4	7	((application or program or software) near6 (launch\$3 or execut\$3 or run\$4 or start\$4 or begin\$4) near6 (authenticat\$3 or check\$3 or verifi\$5 or match\$3)) and ((edge near5 (detect\$3 or determin\$4 or comput\$3)) same (Laplacian or Gaussian or gradient))	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/01/28 16:33
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L6	12	((application or program or software) near6 (launch\$3 or execut\$3 or run\$4 or start\$4 or begin\$4) near6 (authenticat\$3 or check\$3 or verifi\$5 or match\$3)) and (edge near5 (detect\$3 or determin\$4 or comput\$3)) and (Laplacian or Gaussian)	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/01/28 16:35

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